

**Search Notes**

Application/Control No.

10/713,044

Examiner

Thien F. Tran

Applicant(s)/Patent under  
Reexamination

IPPOSHI ET AL.

Art Unit

2811

**SEARCHED**

Class	Subclass	Date	Examiner
257	106, 212	7/15/2005	TT
257	347, 371	7/15/2005	TT
257	653, 654	7/15/2005	TT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR